

# 512K (32K x 16) Static RAM

## Features

- Pin- and function-compatible with CY7C1020V33
- Temperature Ranges
  - Commercial: 0°C to 70°C
  - Industrial: -40°C to 85°C
  - Automotive: -40°C to 125°C
- High speed
  - $t_{AA} = 10, 12, 15$  ns
- CMOS for optimum speed/power
- Low active power
  - 360 mW (max.)
- Automatic power-down when deselected
- Independent control of upper and lower bits
- Available in 44-pin TSOP II

## Functional Description

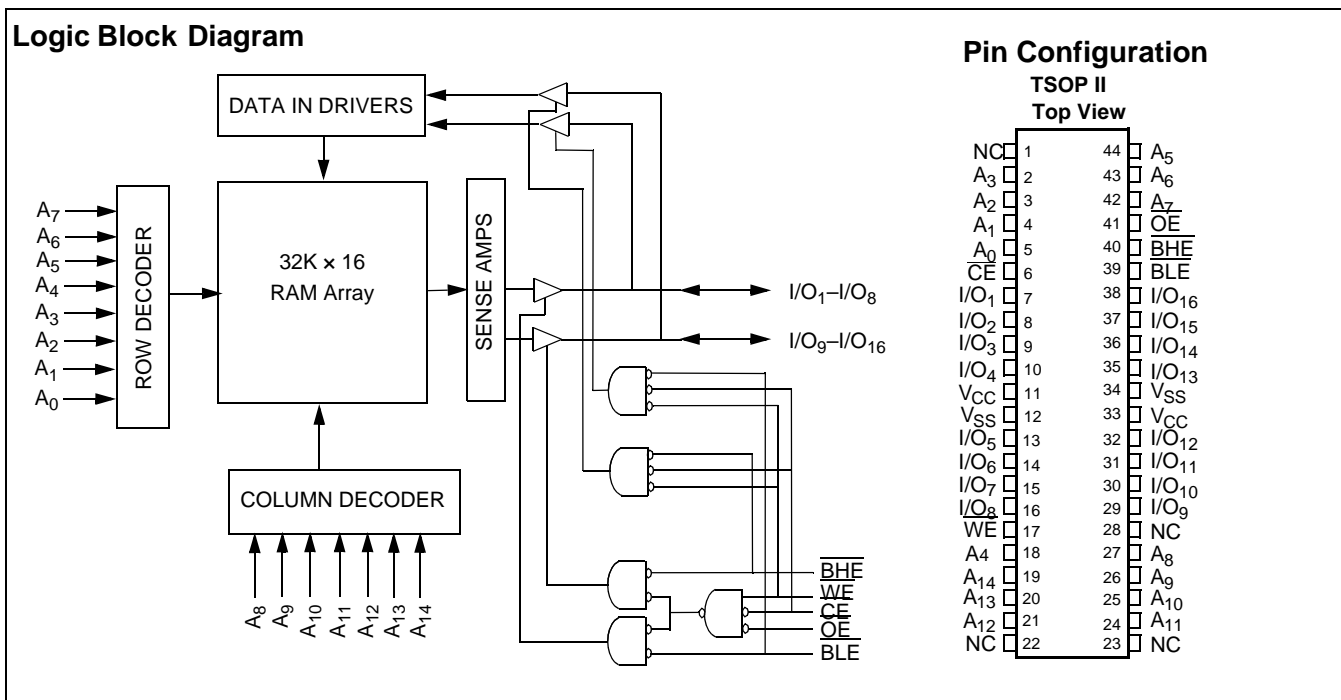
The CY7C1020CV33 is a high-performance CMOS static RAM organized as 32,768 words by 16 bits. This device has an automatic power-down feature that significantly reduces power consumption when deselected.

Writing to the device is accomplished by taking Chip Enable ( $\overline{CE}$ ) and Write Enable ( $\overline{WE}$ ) inputs LOW. If Byte Low Enable ( $\overline{BLE}$ ) is LOW, then data from I/O pins ( $I/O_1$  through  $I/O_8$ ), is written into the location specified on the address pins ( $A_0$  through  $A_{14}$ ). If Byte High Enable ( $\overline{BHE}$ ) is LOW, then data from I/O pins ( $I/O_9$  through  $I/O_{16}$ ) is written into the location specified on the address pins ( $A_0$  through  $A_{14}$ ).

Reading from the device is accomplished by taking Chip Enable ( $\overline{CE}$ ) and Output Enable ( $\overline{OE}$ ) LOW while forcing the Write Enable ( $\overline{WE}$ ) HIGH. If Byte Low Enable ( $\overline{BLE}$ ) is LOW, then data from the memory location specified by the address pins will appear on  $I/O_1$  to  $I/O_8$ . If Byte High Enable ( $\overline{BHE}$ ) is LOW, then data from memory will appear on  $I/O_9$  to  $I/O_{16}$ . See the truth table at the back of this data sheet for a complete description of read and write modes.

The input/output pins ( $I/O_1$  through  $I/O_{16}$ ) are placed in a high-impedance state when the device is deselected ( $\overline{CE}$  HIGH), the outputs are disabled ( $\overline{OE}$  HIGH), the  $\overline{BHE}$  and  $\overline{BLE}$  are disabled ( $\overline{BHE}$ ,  $\overline{BLE}$  HIGH), or during a write operation ( $\overline{CE}$  LOW, and  $\overline{WE}$  LOW).

The CY7C1020CV33 is available in standard 44-pin TSOP Type II package.



**Selection Guide**

		1020CV33-10	1020CV33-12	1020CV33-15	Unit
Maximum Access Time		10	12	15	ns
Maximum Operating Current	Com'l / Ind'l	90	85	80	mA
	Automotive	-	-	85	mA
Maximum CMOS Standby Current	Com'l / Ind'l	5	5	5	mA
	Automotive	-	-	10	mA

**Pin Definitions**

Pin Name	TSOP - Pin Number	I/O Type	Description
A <sub>0</sub> -A <sub>14</sub>	5,4,3,2,18,44,43,42,27,26,25,24,21,20,19	Input	<b>Address Inputs used to select one of the address locations.</b>
I/O <sub>1</sub> -I/O <sub>16</sub>	7-10,13-16,29-32,35-38	Input/Output	<b>Bidirectional Data I/O lines.</b> Used as input or output lines depending on operation.
NC	1,22,23,28	No Connect	<b>No Connects.</b> Not connected to the die.
$\overline{WE}$	17	Input/Control	<b>Write Enable Input, active LOW.</b> When selected LOW, a Write is conducted. When deselected HIGH, a Read is conducted.
$\overline{CE}$	6	Input/Control	<b>Chip Enable Input, active LOW.</b> When LOW, selects the chip. When HIGH, deselected the chip.
$\overline{BHE}$ , $\overline{BLE}$	40,39	Input/Control	<b>Byte Write Select Inputs, active LOW.</b> $\overline{BLE}$ controls I/O <sub>8</sub> -I/O <sub>1</sub> , $\overline{BHE}$ controls I/O <sub>16</sub> -I/O <sub>9</sub> .
$\overline{OE}$	41	Input/Control	<b>Output Enable, active LOW.</b> Controls the direction of the I/O pins. When LOW, the I/O pins are allowed to behave as outputs. When deasserted HIGH, I/O pins are three-stated, and act as input data pins.
V <sub>SS</sub>	12,34	Ground	<b>Ground for the device.</b> Should be connected to ground of the system.
V <sub>CC</sub>	11,33	Power Supply	<b>Power Supply inputs to the device.</b>

### Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature .....	-65°C to +150°C
Ambient Temperature with Power Applied.....	-55°C to +125°C
Supply Voltage on V <sub>CC</sub> to Relative GND <sup>[1]</sup> ....	-0.5V to +4.6V
DC Voltage Applied to Outputs in High-Z State <sup>[1]</sup> .....	-0.5V to V <sub>CC</sub> + 0.5V
DC Input Voltage <sup>[1]</sup> .....	-0.5V to V <sub>CC</sub> + 0.5V

Current into Outputs (LOW).....	20 mA
Static Discharge Voltage.....	> 2001V (per MIL-STD-883, Method 3015)
Latch-up Current.....	> 200 mA

### Operating Range

Range	Ambient Temperature	V <sub>CC</sub>
Commercial	0°C to +70°C	3.3V ± 10%
Industrial	-40°C to +85°C	3.3V ± 10%
Automotive	-40°C to +125°C	3.3V ± 10%

### Electrical Characteristics Over the Operating Range

Parameter	Description	Test Conditions	1020CV33-10		1020CV33-12		1020CV33-15		Unit		
			Min.	Max.	Min.	Max.	Min.	Max.			
V <sub>OH</sub>	Output HIGH Voltage	V <sub>CC</sub> = Min., I <sub>OH</sub> = -4.0 mA	2.4		2.4		2.4		V		
V <sub>OL</sub>	Output LOW Voltage	V <sub>CC</sub> = Min., I <sub>OL</sub> = 8.0 mA		0.4		0.4		0.4	V		
V <sub>IH</sub>	Input HIGH Voltage		2.0	V <sub>CC</sub> + 0.3	2.0	V <sub>CC</sub> + 0.3	2.0	V <sub>CC</sub> + 0.3	V		
V <sub>IL</sub>	Input LOW Voltage <sup>[1]</sup>		-0.3	0.8	-0.3	0.8	-0.3	0.8	V		
I <sub>IX</sub>	Input Load Current	GND ≤ V <sub>I</sub> ≤ V <sub>CC</sub>	Com'l / Ind'l		-1	+1	-1	+1	-1	+1	μA
			Automotive		-	-	-	-	-20	+20	μA
I <sub>OZ</sub>	Output Leakage Current	GND ≤ V <sub>I</sub> ≤ V <sub>CC</sub> , Output Disabled	Com'l / Ind'l		-1	+1	-1	+1	-1	+1	μA
			Automotive		-	-	-	-	-20	+20	μA
I <sub>OS</sub> <sup>[2]</sup>	Output Short Circuit Current	V <sub>CC</sub> = Max., V <sub>OUT</sub> = GND		-300		-300		-300		mA	
I <sub>CC</sub>	V <sub>CC</sub> Operating Supply Current	V <sub>CC</sub> = Max., I <sub>OUT</sub> = 0 mA, f = f <sub>MAX</sub> = 1/t <sub>RC</sub>	Com'l / Ind'l			90		85		80	mA
			Automotive			-		-		85	mA
I <sub>SB1</sub>	Automatic CE Power-down Current —TTL Inputs	Max. V <sub>CC</sub> , CE ≥ V <sub>IH</sub> , V <sub>IN</sub> ≥ V <sub>IH</sub> or V <sub>IN</sub> ≤ V <sub>IL</sub> , f = f <sub>MAX</sub>	Com'l / Ind'l			15		15		15	mA
			Automotive			-		-		20	mA
I <sub>SB2</sub>	Automatic CE Power-down Current —CMOS Inputs	Max. V <sub>CC</sub> , CE ≥ V <sub>CC</sub> - 0.3V, V <sub>IN</sub> ≥ V <sub>CC</sub> - 0.3V, or V <sub>IN</sub> ≤ 0.3V, f = 0	Com'l / Ind'l			5		5		5	mA
			Automotive			-		-		10	mA

### Capacitance<sup>[3]</sup>

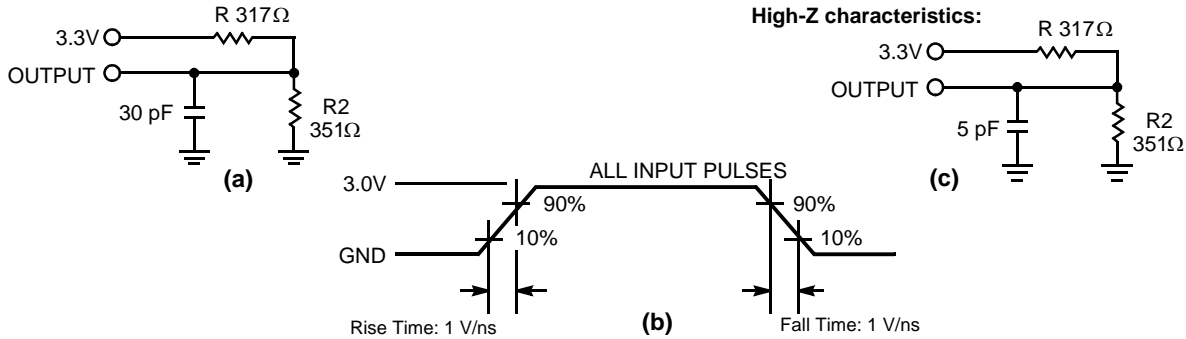
Parameter	Description	Test Conditions	Max.	Unit
C <sub>IN</sub>	Input Capacitance	T <sub>A</sub> = 25°C, f = 1 MHz, V <sub>CC</sub> = 3.3V	8	pF
C <sub>OUT</sub>	Output Capacitance		8	pF

### Thermal Resistance<sup>[3]</sup>

Parameter	Description	Test Conditions	44-pin TSOP-II	Unit
Θ <sub>JA</sub>	Thermal Resistance (Junction to Ambient)	Test conditions follow standard test methods and procedures for measuring thermal impedance, per EIA / JESD51.	76.92	°C/W
Θ <sub>JC</sub>	Thermal Resistance (Junction to Case)		15.86	°C/W

#### Notes:

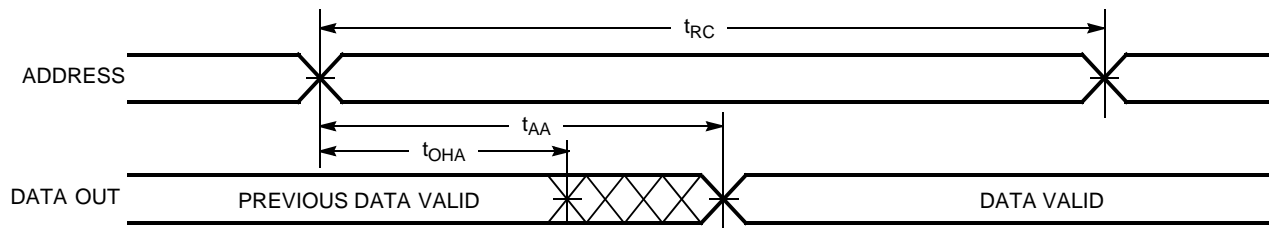
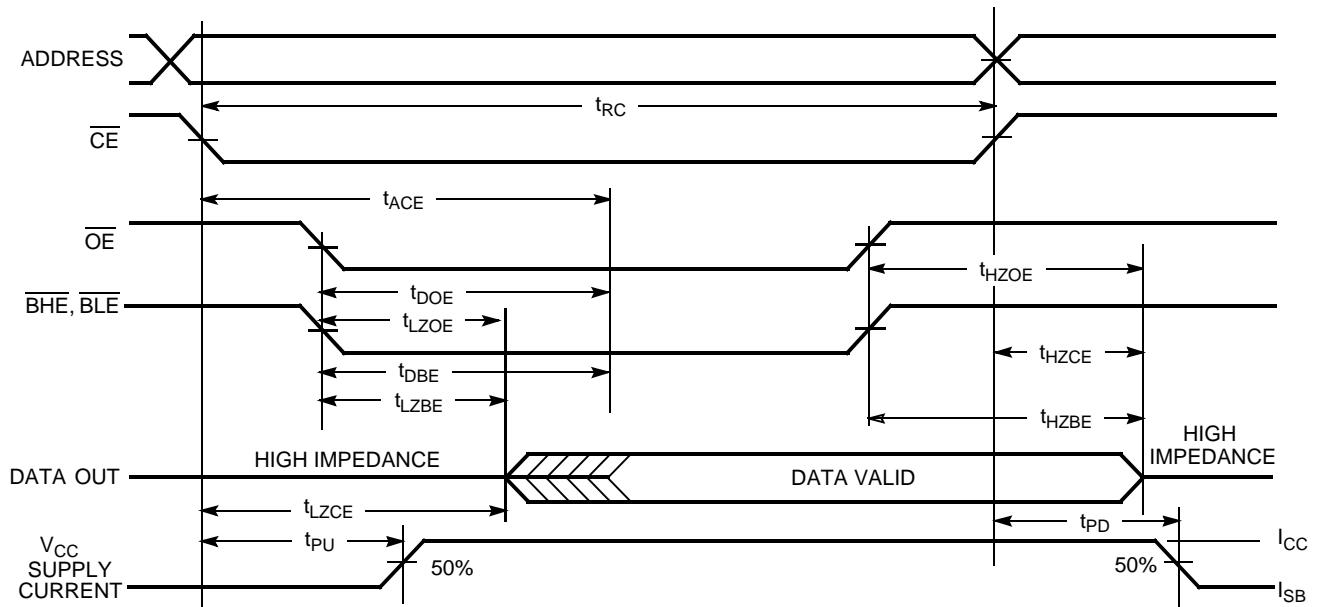
- V<sub>IL</sub> (min.) = -2.0V and V<sub>IH</sub> (max) = V<sub>CC</sub> + 0.5V for pulse durations of less than 20 ns.
- Not more than one output should be shorted at one time. Duration of the short circuit should not exceed 30 seconds.
- Tested initially and after any design or process changes that may affect these parameters.

**AC Test Loads and Waveforms<sup>[4]</sup>**

**Switching Characteristics Over the Operating Range<sup>[4]</sup>**

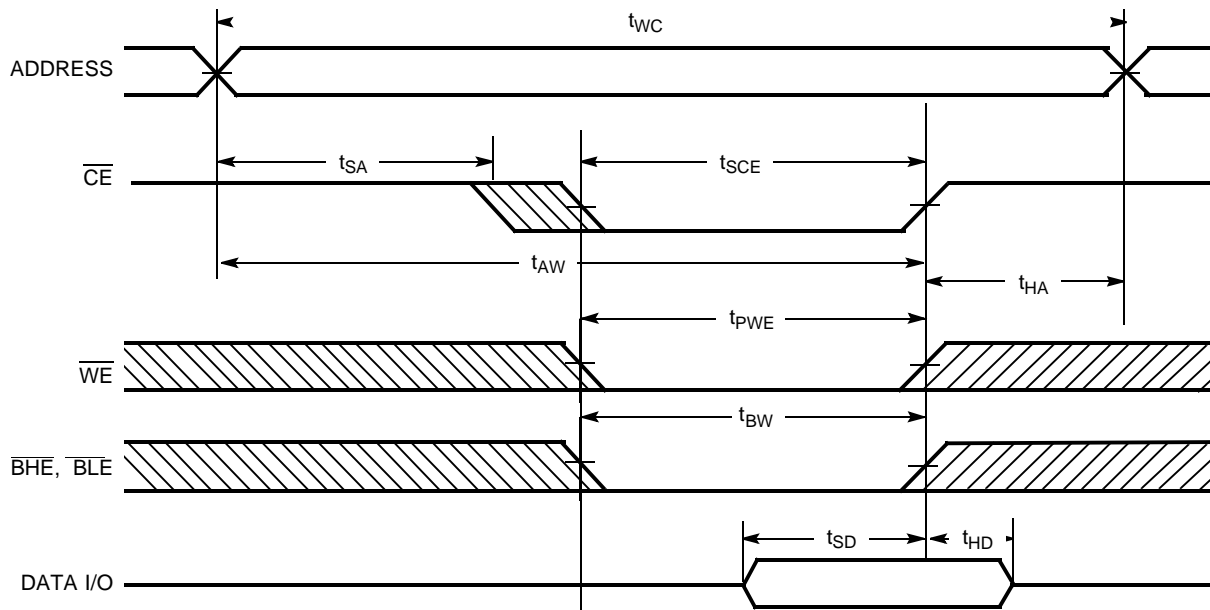
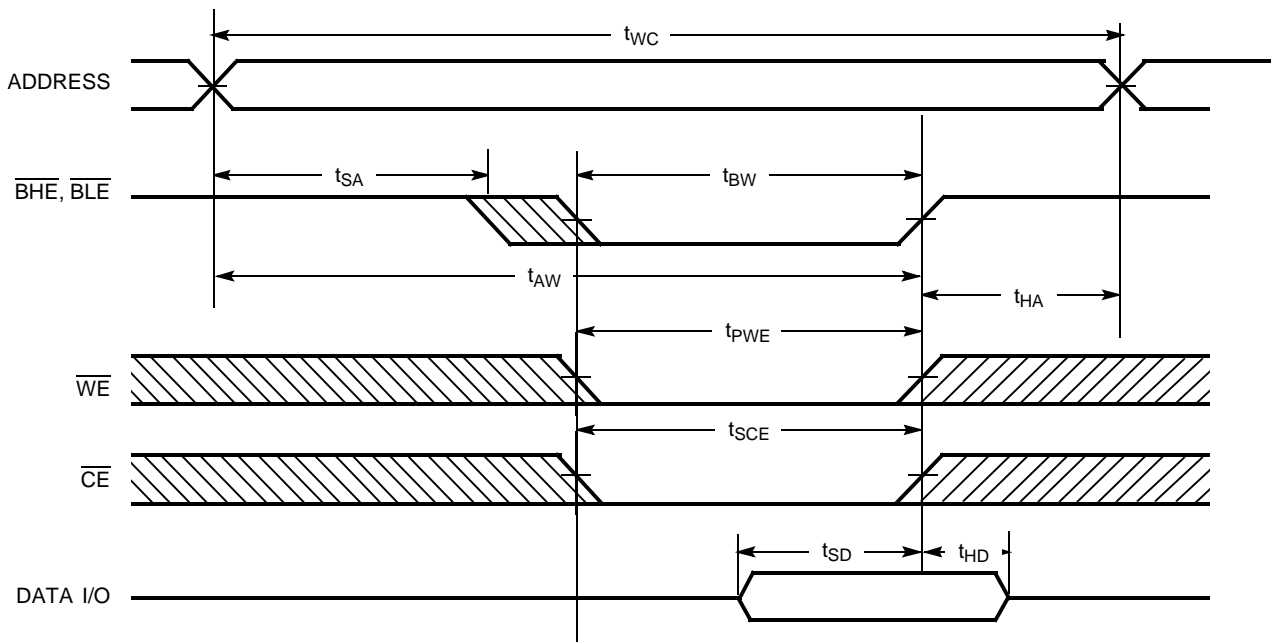
Parameter	Description	1020CV33-10		1020CV33-12		1020CV33-15		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
<b>Read Cycle</b>								
$t_{RC}$	Read Cycle Time	10		12		15		ns
$t_{AA}$	Address to Data Valid		10		12		15	ns
$t_{OHA}$	Data Hold from Address Change	3		3		3		ns
$t_{ACE}$	$\overline{CE}$ LOW to Data Valid		10		12		15	ns
$t_{DOE}$	$\overline{OE}$ LOW to Data Valid		5		6		7	ns
$t_{LZOE}$	$\overline{OE}$ LOW to Low-Z <sup>[5]</sup>	0		0		0		ns
$t_{HZOE}$	$\overline{OE}$ HIGH to High-Z <sup>[5, 6]</sup>		5		6		7	ns
$t_{LZCE}$	$\overline{CE}$ LOW to Low-Z <sup>[5]</sup>	3		3		3		ns
$t_{HZCE}$	$\overline{CE}$ HIGH to High-Z <sup>[5, 6]</sup>		5		6		7	ns
$t_{PU}^{[7]}$	$\overline{CE}$ LOW to Power-up	0		0		0		ns
$t_{PD}^{[7]}$	$\overline{CE}$ HIGH to Power-down		10		12		15	ns
$t_{DBE}$	Byte Enable to Data Valid		5		6		7	ns
$t_{LZBE}$	Byte Enable to Low-Z	0		0		0		ns
$t_{HZBE}$	Byte Disable to High-Z		5		6		7	ns
<b>Write Cycle<sup>[8]</sup></b>								
$t_{WC}$	Write Cycle Time	10		12		15		ns
$t_{SCE}$	$\overline{CE}$ LOW to Write End	8		9		10		ns
$t_{AW}$	Address Set-up to Write End	7		8		10		ns
$t_{HA}$	Address Hold from Write End	0		0		0		ns
$t_{SA}$	Address Set-up to Write Start	0		0		0		ns
$t_{PWE}$	$\overline{WE}$ Pulse Width	7		8		10		ns
$t_{SD}$	Data Set-up to Write End	5		6		8		ns
$t_{HD}$	Data Hold from Write End	0		0		0		ns
$t_{LZWE}$	$\overline{WE}$ HIGH to Low-Z <sup>[5]</sup>	3		3		3		ns
$t_{HZWE}$	$\overline{WE}$ LOW to High-Z <sup>[5, 6]</sup>		5		6		7	ns
$t_{BW}$	Byte Enable to End of Write	7		8		9		ns

**Notes:**

- Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3.0V.
- At any given temperature and voltage condition,  $t_{HZCE}$  is less than  $t_{LZCE}$ ,  $t_{HZOE}$  is less than  $t_{LZOE}$ , and  $t_{HZWE}$  is less than  $t_{LZWE}$  for any given device.
- $t_{HZOE}$ ,  $t_{HZBE}$ ,  $t_{HZCE}$ , and  $t_{HZWE}$  are specified with a load capacitance of 5 pF as in part (c) of AC Test Loads. Transition is measured  $\pm 500$  mV from steady-state voltage.
- This parameter is guaranteed by design and is not tested.
- The internal Write time of the memory is defined by the overlap of  $\overline{CE}$  LOW,  $\overline{WE}$  LOW and  $\overline{BHE}$  /  $\overline{BLE}$  LOW.  $\overline{CE}$ ,  $\overline{WE}$  and  $\overline{BHE}$  /  $\overline{BLE}$  must be LOW to initiate a Write, and the transition of these signals can terminate the Write. The input data set-up and hold timing should be referenced to the leading edge of the signal that terminates the Write.

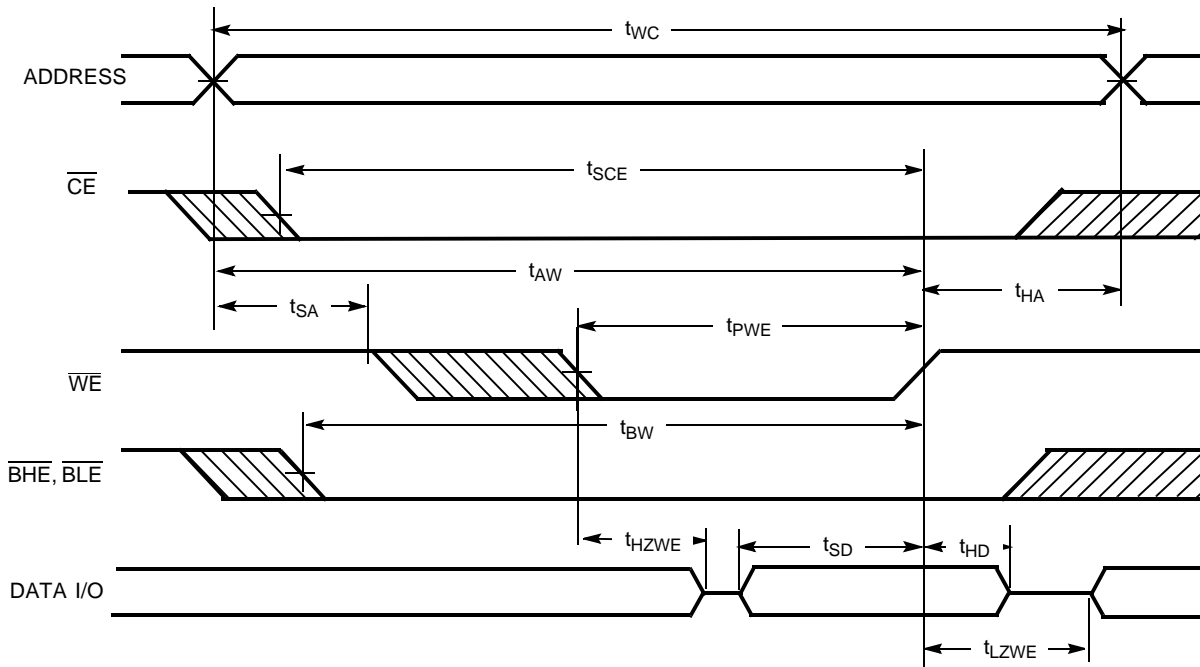
**Switching Waveforms**
**Read Cycle No. 1<sup>[9, 10]</sup>**

**Read Cycle No. 2 (OE Controlled)<sup>[10, 11]</sup>**

**Notes:**

9. Device is continuously selected.  $\overline{OE}$ ,  $\overline{CE}$ ,  $\overline{BHE}$  and/or  $\overline{BLE}$  =  $V_{IL}$ .
10.  $\overline{WE}$  is HIGH for Read cycle.
11. Address valid prior to or coincident with  $\overline{CE}$  transition LOW.

**Switching Waveforms (continued)**
**Write Cycle No. 1 ( $\overline{\text{CE}}$  Controlled)<sup>[12, 13]</sup>**

**Write Cycle No. 2 ( $\overline{\text{BLE}}$  or  $\overline{\text{BHE}}$  Controlled)**

**Notes:**

12. Data I/O is high impedance if  $\overline{\text{OE}}$  or  $\overline{\text{BHE}}$  and/or  $\overline{\text{BLE}} = V_{\text{IH}}$ .  
 13. If  $\overline{\text{CE}}$  goes HIGH simultaneously with  $\overline{\text{WE}}$  going HIGH, the output remains in a high-impedance state.

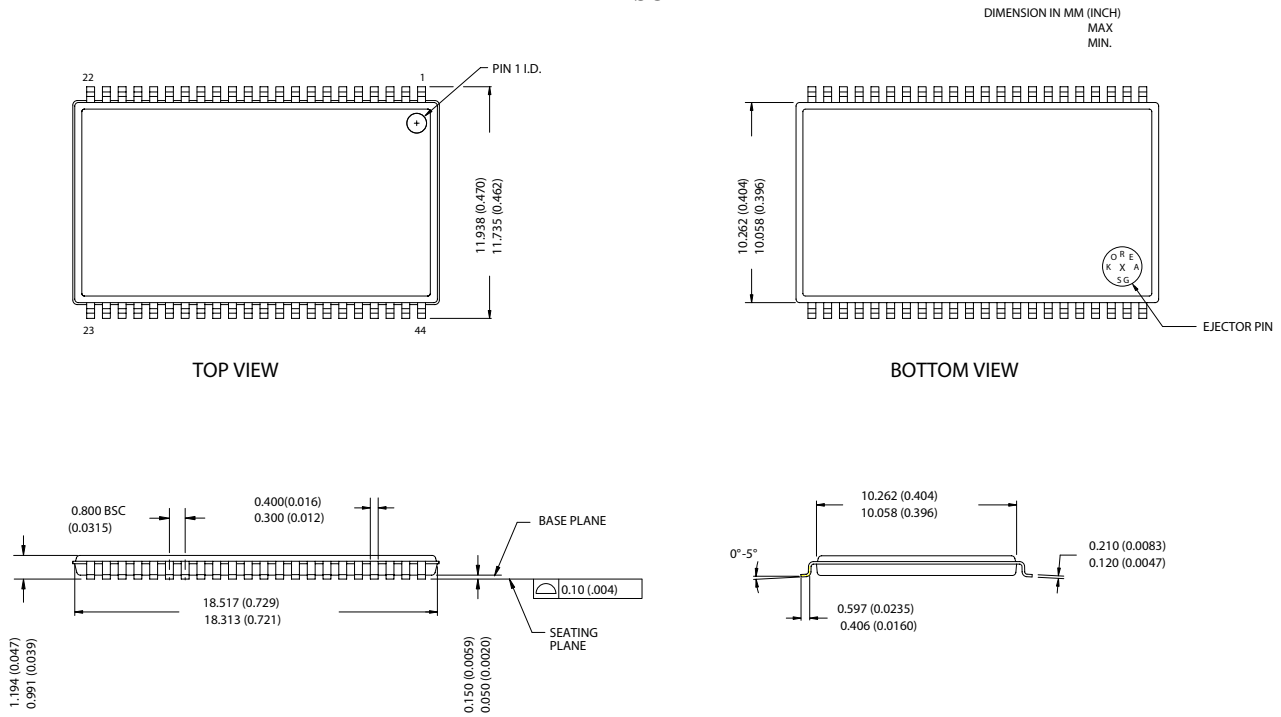
**Switching Waveforms** (continued)

**Write Cycle No. 3 ( $\overline{WE}$  Controlled,  $\overline{OE}$  LOW)**

**Truth Table**

CE	OE	WE	BLE	BHE	I/O <sub>1</sub> -I/O <sub>8</sub>	I/O <sub>9</sub> -I/O <sub>16</sub>	Mode	Power
H	X	X	X	X	High-Z	High-Z	Power-down	Standby ( $I_{SB}$ )
L	L	H	L	L	Data Out	Data Out	Read—All bits	Active ( $I_{CC}$ )
			L	H	Data Out	High-Z	Read—Lower bits only	Active ( $I_{CC}$ )
			H	L	High-Z	Data Out	Read—Upper bits only	Active ( $I_{CC}$ )
L	X	L	L	L	Data In	Data In	Write—All bits	Active ( $I_{CC}$ )
			L	H	Data In	High-Z	Write—Lower bits only	Active ( $I_{CC}$ )
			H	L	High-Z	Data In	Write—Upper bits only	Active ( $I_{CC}$ )
L	H	H	X	X	High-Z	High-Z	Selected, Outputs Disabled	Active ( $I_{CC}$ )
L	X	X	H	H	High-Z	High-Z	Selected, Outputs Disabled	Active ( $I_{CC}$ )

**Ordering Information**

Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
10	CY7C1020CV33-10ZC	Z44	44-lead TSOP Type II	Commercial
	CY7C1020CV33-10ZXC	Z44	44-lead TSOP Type II (Pb-Free)	Commercial
	CY7C1020CV33-10ZI	Z44	44-lead TSOP Type II	Industrial
12	CY7C1020CV33-12ZC	Z44	44-lead TSOP Type II	Commercial
	CY7C1020CV33-12ZI	Z44	44-lead TSOP Type II	Industrial
15	CY7C1020CV33-15ZC	Z44	44-lead TSOP Type II	Commercial
	CY7C1020CV33-15ZXC	Z44	44-lead TSOP Type II (Pb-Free)	Commercial
	CY7C1020CV33-15ZI	Z44	44-lead TSOP Type II	Industrial
	CY7C1020CV33-15ZXI	Z44	44-lead TSOP Type II (Pb-Free)	Industrial
	CY7C1020CV33-15ZSE	Z44	44-lead TSOP Type II	Automotive
	CY7C1020CV33-15ZSXE	Z44	44-lead TSOP Type II (Pb-Free)	Automotive

**Package Diagrams**
**44-Pin TSOP II Z44**


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## Document History Page

Document Title: CY7C1020CV33 512K (32K x 16) Static RAM  
Document Number: 38-05133

REV.	ECN NO.	Issue Date	Orig. of Change	Description of Change
**	109428	12/16/01	HGK	New Data Sheet
*A	115045	05/30/02	HGK	I <sub>CC</sub> and I <sub>SB1</sub> data modified
*B	117615	08/14/02	DFP	Pin 1= NC Pin 18 = A4; remove SOJ package option; remove 8ns option.
*C	262949	See ECN	RKF	Added Automotive Specs to Datasheet
*D	334398	See ECN	SYT	Added Lead-Free Product Information